The e ective $S-m$ atrix from conductance data in a quantum wave guide: D istinguishing the indistingu ishable

G ursoy B. Akguc¹, Jorge Flores ${ }^{1}$, and Sergey Yu. K un ${ }^{1 ; 2 ; 3}$<br>${ }^{1}$ C entro de $C$ iencias $F$ isicas,<br>Universidad N acional Autonom a de M exico, Cuemavaca, M orelos, M exico<br>${ }^{2} \mathrm{C}$ enter for N on linear P hysics, R SP hysSE, $T$ he Australian $N$ ational U niversity, C anberra ACT 0200, Australia and<br>${ }^{3}$ D epartm ent of $T$ heoretical Physics, R SP hysSE The A ustralian $N$ ational U niversity, C anberra ACT 0200, A ustralia

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#### Abstract

W e consider two di erent stationary random processes whose probability distributions are very close and indistinguishable by standard tests for large but lim tited statistics. Yet we dem onstrate that these processes can be reliably distinguished. T he $m$ ethod is applied to analyze conductance uctuations in coherent electron transport through nanostructures.


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The quantum $m$ echanical scattering by com plex system s has been a problem of long-standing interest. This problem is of a great im portance in nuclear, molecular and m esoscopic physics cess can be often analyzed in term s of tw o distinct time scales: (i) a prom pt response due to direct processes and (ii) a tim e-delayed scattering $m$ echanism. In $n u-$ clear physics the tim e-delayed $m$ echanism is associated w ith the form ation of an equilibrated com pound nucleus [1] , 'ricl. Sim ilarly, tim e-delayed processes have been encountered in the study of coherent electron transport
 tim e scales introduce tw o di erent energy scales. N am ely, the scattering am plitude of direct processes is a sm ooth function ofenergy and it can be taken as an energy averaged $S \mathrm{~m}$ atrix. T he scattering am plitude oftim e-delayed process, on the other hand, is an energy dependent function which uctuates rapidly around zero. K now ledge of the energy averaged $S$ m atrix allow $s$ one to construct a

$S$ m atrix for ballistic electron scattering $o$ nanostructures can be calculated num erically if the geom etry of the nanodevioe, as w ell as the shape, size and num ber of propagating $m$ odes of the leads, and spatial distribution of disorder are know n precisely. Then, having calculated the energy dependence of the $S-m$ atrix one can directly separate it into an energy averaged direct reaction com ponent and a uctuating one. In experim ents, the detailed inform ation about the conducting devioe $m$ ay not be alw ays available. For exam ple, wallim perfections and unknow $n$ spacial distribution of disorder does not allow to evaluate the contribution of direct processes. D isorder can also block leads in an unknow $n m$ anner reducing the num ber of propagating $m$ odes. $T$ his $m$ otivates us to consider the \inverse problem ": W hat inform ation about relative contributions of direct and tim e-delayed processes and num ber of propagating $m$ odes in the leads
can be obtained from the analysis of the transm ission energy uctuations provided the above $m$ entioned characteristics of the nanodevice are unknow $n$ ?

For concreteness we consider the transm ission betw een horizontally oriented leads for the tw o types of geom etry of wave guides (W G ) (Fig. 1). For experim ental purposes, we refer the reader to reference [id for a possible im plem entation of this system. The left leads of both W G can accom m odate a single propagating channelonly. For the W G (b) the right lead also accom $m$ odates only one channel $(\mathbb{N}=1)$, while for $W G(a)$ it has $N \quad 2$ open channels. In addition, both $W G$ (a) and (b) have $\mathrm{N}_{\mathrm{a}} \quad 1$ and $\mathrm{N}_{\mathrm{b}} \quad 1$ open channels show n by arrow s pointing dow $n$ at the bottom of G w ith $\mathrm{N}_{\mathrm{a}} \quad \mathrm{N} . \mathrm{D}$ isorder is $m$ odeled by scatterers (show $n$ in $F$ ig. 1 in white) having in nitely high potentialwalls.

Transm ission betw een the horizontally oriented leads for the (a) and (b) W G in Fig. 1 is given by

$$
\begin{equation*}
\left.T(E)=X_{j=1}^{X^{N}} j_{1 j}(E)\right\}^{2}: \tag{1}
\end{equation*}
$$

$H$ ere $S_{1 j}(E)$ are the $S m$ atrix elem ents for scattering betw een left leads $\backslash 1$ " and right leads $j$, and $E$ is electron energy. For the $W$ G (b) in Fig. 1 the sum (1) contain only a single term $(\mathbb{N}=1)$. W e use the decom position $S_{1 j}(\mathbb{E})=\left\langle S_{1 j}\right\rangle+S_{1 j}(E)$, where $\left\langle S_{1 j}\right\rangle$ are energy averaged $S$ m atrix elem ents, and $S_{1 j}(E)$ are energy uctuating ones. $W$ e ghose the spacial distribution of disorder such that (i) ${ }_{j}{ }^{j}<S_{1 j}>\frac{?}{j} 1$, and (ii) transm ission betw een the horizontal leads and open channels at the bottom ofboth (a) and (b) W G in Fig. 1 is $m$ ostly due to tim e-delayed processes. $T$ herefore, the overall am ount of direct processes for the transm ission betw een di erent channels is $m$ uch less than that for the overall am ount of tim e-delayed processes. A lso, due to the presence of disorder, the dynam ics of the classical


F IG . 1: T he electron probability distribution inside the wave guides for an arbitrary chosen electron energy. The arrow s show incident unit current from left and current leaving the system from the right. T he white circular regions represent in nite potential barriens. T he wave guide (a) does not show direct processes and (b) has direct processes (see text).
counterpart in the interaction region of W G (a) and (b) in $F$ ig. 1 is chaotic. Since the total num bers of open channels, $\mathrm{N}+\mathrm{N}_{\mathrm{a}}+1$ and $\mathrm{N}+2$, are m uch greater than unity, we are in the regim e of E ricson uctuations when electron resonance states $w$ thin the W G are overlapping. $T$ hen each individual uctuating $S$ m atrix elem ent can be considered as a G aussian random process. Nam ely, real and in aginary parts of each individual $S_{1 j}(E)$ in sum (1) are distributed by a G aussian law, are uncorre-

$T$ he PD for $y=T(E)=\langle T(E)\rangle$ (so that $\langle y\rangle=1$ ) is given by $\left.{ }^{-1}{ }^{1}\right]$,

$$
\begin{align*}
& \left.P_{N}(y)=N\left(\begin{array}{ll}
1 & y d
\end{array}\right)^{1}\left(y=y_{d}\right)^{(N \quad} \quad 1\right)=2 \\
& \left.\exp \left[\begin{array}{ll}
N(\mathrm{yd}+\mathrm{y})=(1 & \mathrm{y}
\end{array}\right)\right] \\
& I_{N} \quad{ }_{1}\left[2 N \quad\left(y_{d} y\right)^{1=2}=\left(\begin{array}{ll}
1 & \mathrm{y}
\end{array}\right)\right]: \tag{2}
\end{align*}
$$

Here $I_{N} \quad 1$ ( ) is the modi ed Bessel function of $(\mathbb{N} \quad 1)$ order and $Y_{d}={ }_{j} j<S_{1 j}>f=\langle T(E)\rangle$ is the relative contribution of direct processes to the total trans$m$ ission. The PD of Eq. (2) is exact if all $S_{1 j}(E)$ $w$ ith di erent $j$ are uncorrelated and have the sam e dispersions. Otherw ise this PD is an approxim ation for which $N$ should be understood as an e ective number of independent channels $N_{\text {eff }}<N$. $_{P}$ It is given by the nom alized variance of $T(E)=P_{j=1}^{N} j S_{1 j}(E) \mathcal{J}$ : $<\mathrm{T}(\mathbb{E})^{2}>=<\mathrm{T}(E)>^{2} \quad 1=1=\mathrm{N}_{\mathrm{eff}}$ 。

For the $W$ G (b) in $F$ ig. 1 one has to put $N=1$ in Eq. (2). For $y_{d}=0, E q$. (2) takes the form of $a^{2}-$ distribution $w$ ith 2 N degrees of freedom ['5]:

$$
\begin{equation*}
P_{N}(y)=N[(\mathbb{N})]^{1}(\mathbb{N} y)^{N} \quad{ }^{1} \exp (\quad N y) ; \tag{3}
\end{equation*}
$$



F IG . 2: The probability distributions of transm ission. T he solid lines, w ith decreasing thicknesses, show the theoretical curves for $\mathrm{N}=1, \mathrm{~N}=5$ (Eq. (2)) and $\mathrm{N}=10$ (Eq. (3)) channelcases respectively. T he histogram is constructed from the num erical data for $\mathrm{N}=1$ and $\mathrm{y}_{\mathrm{d}}=(0: 9)^{1=2}$, as an exam ple. T he inset show s a blow up of the transm ission probability distributions dem onstrating that the di erence betw een them around their $m$ axim a does not exceed 4\% .
where $(\mathbb{N})$ is $G a m m$ a function. $N$ ote that the variance of $y$ is given by $\left\langle\mathrm{y}^{2}\right\rangle \quad 1=\left(\begin{array}{ll}1 & \vdots\end{array}\right)=\mathrm{N} \quad\left[\begin{array}{l}\text { 5n }\end{array}\right]$.

A s an exam ple, we consider tw o possible cases for $W$ G (a) in Fig. 1: (i) $N=10$ and $y_{d}=0$, the latter due to com plete blocking of the direct paths betw een the leads by disorder, and (ii) $N=5$ and $y_{d}=(0: 8)^{1=2}$. A lso suppose that, for $W G(b)$, for which $N=1, y_{d}=(0: 9)^{1=2}$. For the above three sets of N and Yd values the variance of conductance $y$ is the sam $e$ and equals 0.1. T he question is: $C$ an we distinguish these three cases by analyzing PD ofy in Eq. (2)?

In Fig. Yd. The three distributions are very close. W e perform ed a 2 test and found that, even for as $m$ any as 28000 independent realizations of $y$ for each of the three cases, the distributions are indistinguishable at a 99\% con dence level. A nd, to the best of our know ledge, there is currently no any other statistical test which would allow to distinguish betw een the three di erent stochastic processes. Yet, in what follow s, we show that the problem of distinguishing betw een these random processes can be solved.

W e w ill refer to the $y$ as $y_{i}$, where the index i stands for di erent independent realizations of the process. Let us transform to new random variables $s_{i j}=\left(y_{i}+y_{j}\right)=2$, $r_{i j}=\left(y_{i} \quad y_{j}\right)=2 s_{i j} w$ th $i \not j$. O ne can now easily nd the joint probability distribution K ( $\mathrm{s} ; \mathrm{r}$ ). T he analytical calculations are form ally sim ilar to those of $R$ ef. [1] for the analysis of the correlation betw een cross section and analyzing power in the regim e of Ericson uctuations in


FIG. 3: The plot of $<r^{2}(s)>$ vs. $s$ corresponding to the sam e $N$ (shown in inset) and $y_{d}$ values as those used for the analysis of the probability distributions in Fig. 2. D otted, dashed and dotted-dashed lines are theoretical predictions (Eq. (4) .
nuclear reactions. W ithout presenting the explicit result for $K(s ; r)$ we point out that, for $y_{d}=0, s$ and $r$ are statistically independent. On the contrary, for $y_{d} \in 0, s$ and $r$ correlate, the bigger $y_{d}$ the stronger this correlation is.

W e calculate $<\mathrm{r}^{2}(\mathrm{~s})>$ :

$$
<r^{2}(s)>=\left[\begin{array}{ll}
1 & \bar{K}_{2}+3()=I_{2 N} \tag{4}
\end{array} \quad 1()\right]=(2 N+1) ;
$$

where $=4 \mathrm{~N}\left(\mathrm{Y}_{\mathrm{d}} \mathrm{S}\right)^{1=2}=(1 \quad \mathrm{Jd})$, and take into account the constraint $\left(1 \quad y_{d}^{2}\right)=\mathrm{N}=0: 1$. In Fig . '3'1, we show $<r^{2}(s)>$ for the three cases. W e have generated 28000 realizations for each case and used all possible i_ j combinations for $s_{i j}$ and $r_{i j}$. The data in $F$ ig. obtained by dividing the $s_{i j}$ into 5 bins for each case and taking the average of $r^{2}(s)$ and $s$ for each bin. It is evident from F ig. 1 cases. T he uctuations around the theoretical curves are determ ined by the num ber of realizations. E rrorbars are calculated num erically from standard deviations of 100 data sets each consisting 28000 y realizations. W e found that it is possible to distinguish the $\mathrm{N}=1$ and $\mathrm{N}=10$ processes in 97\% of cases for 210 realizations of $y$. This drops to $85 \%$ for 140 realizations.

W e apply the new $m$ ethod to distinguish betw een (a) and (b) in Fig. 1 from the conductance uctuation data. W e im plem ented a nite elem ent solution of the Schrodinger equation $\left.\left[\overline{9}, r_{1}^{1}\right]_{1}^{1}\right]$. C alculations were perform ed on the energy range which allows 5 propagating channels in the right lead for $W$ G (a) in $F$ ig. 1. B oth left leads for $W$ G (a) and (b) as well as the right lead for W G (b) in F ig. 1 accom m odate a single channel. In addition, forboth (a) and (b) W G in Fig. 1, there are 20-25 propagating channels from the low er part of the devioes. A unit current is directed from left. W e are interested in the transm ission probability from the left to the right side. Spacial disorder distribution for $W G(a)$ in $F i g .1$ w as chosen to block the direct paths betw een the left and


FIG. 4: The plot of $<r^{2}(s)>$ vs. $s$ for the $w$ ave guides shown in Fig. $l_{1}^{1}$. The dashed and dotted-dashed lines are theoretical estim ates (Eq. (4)) and thin and thick solid lines are num erical calculations for $\mathrm{N}=1$ ( w ith direct processes) and for $\mathrm{N}=5$ (w thout direct processes) cases respectively. $T$ he inset show s conductance distributions (lines) for (a) $\mathrm{N}=$ 1, w ith direct processes (Eq. (2)), and (b) $N=5$, w ithout direct processes (Eq. (3)). H istogram s are constructed from the num erical data.
right leads, i.e. to m axim ally suppress direct processes. This was con $m$ ed by $S$-m atrix num erical data, which yielded negligible absolute value of the energy averaged $S \cdot m$ atrix, and by the fact that the norm alized variance of conductance uctuations is close to 02 . For W G (b) in $F$ ig. 1 the extension of leads into the cavity is adjusted to have relative contribution of direct process $y_{d} \quad 0: 9$ so that the nom alized variance of conductance uctuations is close to 02 , i.e. to that forW G (a) in $F$ ig. 1. For both (a) and (b) W G in Fig. 1 we used di erent disorder distributions to increase the statistics. T he overall num ber of independent realizations of transm ission values $y$ for each type of geom etry in Fig. 1 w as around 150.

In Fig. 4 we present PD of $y$ for the (a) and (b) $W$ G of F ig. 1. ${ }^{2}$ test does not allow to distinguish the tw o PD. Yet, from Fig. 4 one can see that for the $\mathrm{N}=$ 1 case, in the presence of direct processes, < $r^{2}(s)>$ strongly increases when $s$ decreases. On the contrary, for the $\mathrm{N}=5$ case, when direct processes are absent, < $r^{2}(s)>$ for $s<1$ is close to a constant. $W$ e have checked that even for each single con guration of disorder, when we have only about 30-40 independent realizations of the transm ission values for each (a) and (b) W G , < $r^{2}$ (s) $>$ increases alw ays notioeably faster for the $\mathrm{N}=1$ casew th direct processes as com pared to the $\mathrm{N}=5$ case w ithout direct processes. O $n$ the other hand, the rise of $<r^{2}(s)>$ $w$ hen $s$ decreases of $s$ for $N=1 \mathrm{w}$ th direct processes is much stronger than that predicted by Eq. (4). In order to nd a possible reason for this we analyzed the $P D$ of uctuating $S$ m atrix elem ents. $W$ e found that (i)
$S_{11}(E)$ are not distributed isotropically in the com plex plane, (ii) the PD of realand im aginary parts of $S_{11}(E)$
are not $G$ aussian, and (iii) real and im aginary parts of
$S_{11}(E)$ are correlated. Therefore, the reason for the discrepancy betw een the data and theoretical line in F ig. 4 for $\mathrm{N}=1$ is that the conditions to derive Eq. (4) are not $m$ et. Yet, the distribution for transm ission is not sensitive to the deviation of the PD of $S_{1_{1}}(\mathbb{E})$ from its isotropic $G$ aussian distribution in the com plex plane and correlation betw een realand im aginary parts of $S_{11}(\mathbb{E})$.

In conclusion, we have suggested a $m$ ethod to distinguish between di erent stationary random processes
whose PD are very close and indistinguishable by standard tests for large but lim ited statistics. The m ethod has been applied to analyze conductance uctuations in coherent electron transport through W G.We found that the $m$ ethod proposed here, unlike the analysis of PD of transm ission, is sensitive to (i) the deviation of PD of uctuating transm ission am plitudes from isotropic G aussian statistics in the com plex plane, and (ii) correlations betw een realand im aginary parts of the uctuating transm ission am plitudes.
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